Search Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/734,544	KIM ET AL.
Examiner	Art Unit
John P. Sheehan	1742

SEARCHED					
Subclass	Date	Examiner			
	<u> </u>				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	3/18/2006	JS	